



PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Docket No: Q77506

Satoshi ARAKAWA

Appln. No. 10/662,328

Group Art Unit: 2878

Confirmation No. 9177

Examiner: Constantine Hannaher

Filed: September 16, 2003

For:

RADIATION IMAGE SENSOR AND METHOD OF PRODUCING THE SAME

INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. §§ 1.97 and 1.98

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

In accordance with the duty of disclosure under 37 C.F.R. § 1.56, Applicant hereby notifies the U.S. Patent and Trademark Office of the documents which are listed on the attached PTO/SB/08 A & B (modified) form and/or listed herein and which the Examiner may deem material to patentability of the claims of the above-identified application.

One copy of each of the listed documents is submitted herewith.

The present Information Disclosure Statement is being filed after the later of three months from the application's filing date and the mailing date of the first Office Action on the merits, but before a Final Office Action, Notice of Allowance, or an action that otherwise closes prosecution in the application (whichever is earlier). Because the references were previously submitted and made of record concurrently with the application, no fee is believed to be

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INFORMATION DISCLOSURE STATEMENT

U.S. Appln. No. 10/662,328

required. If, however, a fee is due, the fee of \$180.00 under 37 C.F.R. § 1.17 should be charged

to deposit account no. 19-4880

The submission of the listed documents is not intended as an admission that any such

document constitutes prior art against the claims of the present application. Applicant does not

waive any right to take any action that would be appropriate to antedate or otherwise remove any

listed document as a competent reference against the claims of the present application.

The USPTO is directed and authorized to charge all required fees, except for the Issue

Fee and the Publication Fee, to Deposit Account No. 19-4880. Please also credit any

overpayments to said Deposit Account. A duplicate copy of this paper is attached.

Respectfully submitted,

Registration No. 41,239

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WASHINGTON OFFICE

23373
CUSTOMER NUMBER

Date: October 14, 2005

	Special for Form 1449 A & B/PTC)	Complete if Known		
6	PE 40		Application Number	10/662,328	
	SINFORMATIC	N DISCLOSURE	Confirmation Number	9177	
	CI 14 2005 STATEMENT	BY APPLICANT	Filing Date	September 16, 2003	
٠,	C() 4 (10)		First Named Inventor	Satoshi ARAKAWA	
	(use as many si	heets as necessary)	Art Unit	2878	
	(use as many si		Examiner Name	Constantine Hannaher	
	Sheet 1	of 1	Attorney Docket Number	Q77506	

			U.S. 1	PATENT DOCUME	ENTS
Examiner	Cite	Document Number		Publication Date	
Initials*	No.1	Number	Kind Code ² (if known)	MM-DD-YYYY	Name of Patentee or Applicant of Cited Document
		US			

FOREIGN PATENT DOCUMENTS							
Examiner	iner Cite	Foreign Patent Document			Publication Date	Name of Patentee or	
Initials*	No.1	Country Code ³	Number ⁴	Kind Code ⁵ (if known)	MM-DD-YYYY	Applicant of Cited Document	Translation ⁶
							
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NON PATENT LITERATURE DOCUMENTS					
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city, and/or country where published.			
		"Comparative Study of PbI ₂ and HgI ₂ as Direct Detector Materials for High Resolution X-ray Image Sensors"; authors: Robert A. Street et. al.; SPIE (2001), vol. 4320, pp. 1-12			
	_	"X-ray Detectors for Digital Radiography"; authors: M.J. Yaffe and J.A. Rowlands; Physical Medical Biology; pp. 1-39 - 1997			
		"Experimental Evaluation of a novel CdZnTe flat-panel X-ray Detector for digital radiography and fluoroscopy"; authors: Satoshi Tokuda, et al.; SPIE (2001), vol. 4320, pp. 140-147			
		"Amorphous Silican X-ray Image Sensor"; authors: J. Chabbal, et al.; SPIE (2001), vol. 2708, pp. 499-510			

Examiner Signature	Date Considered	

^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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